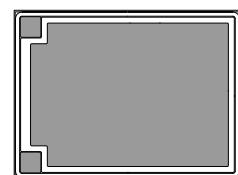
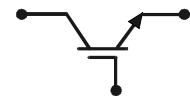


# Trench XPT IGBT Chip



Type	V <sub>CE</sub> [V]	I <sub>C</sub> [A]	Chip Size [mm] x [mm]	Package	Ordering Code
IX150T06M-AG	650	300	14.2 10.6	sawn on foil <input type="checkbox"/> unsawn wafer <input type="checkbox"/> in waffle pack <input checked="" type="checkbox"/>	tbd tbd tbd

## Features / Advantages:

- Easy paralleling due to the positive temperature coefficient of the on-state voltage
- Rugged Trench XPT design (Xtreme light Punch Through) results in:
  - short circuit rated for 10  $\mu$ sec.
  - very low gate charge
  - square RBSOA @ 2x I<sub>C</sub>
  - low EMI
  - $T_{vjm} = 175^{\circ}\text{C}$
- Thin wafer technology combined with the XPT design results in a competitive low  $V_{ce(\text{sat})}$
- Solderable/sinterable frontside metallization for highly reliable interconnection technology

## Applications:

- AC motor drives
- Solar inverter
- Medical equipment
- Uninterruptible power supply
- Air-conditioning systems
- Welding equipment

## Mechanical Parameters

Parameters	Conditions	Ratings	Unit
Area active		130.02	mm <sup>2</sup>
Area total		150.52	mm <sup>2</sup>
Wafer size Ø		150	mm
Thickness		70	μm
Material	SiFZ	Orientation	<100>
Max. possible chips	per wafer		
Passivation	front side		SiN
Metallization	top side		Al / Ti / Ni / Ag
	backside		Al / Ti / Ni / Ag
Recom. wire bonds (Al)	Gate	Number / Ø	2 / 300 - / μm
Solder Pad (front side)	Emitter	Area	117.7 mm <sup>2</sup>
Reject Ink Dot Size	Ø		0.4-1.0 mm
Recom. Storage Environment	in orig. container, in dry nitrogen		< 6 month
	Storage Temperature (T <sub>stg</sub> )		-40 ... 40 °C
Soldering/sintering temperature (5 min.)			max. 360 °C
Virtual junction temperature T <sub>vj</sub>			-40 ... 175 °C

## Electrical Parameters

Symbol	Definition	Conditions			Ratings		
					min.	typ.	max.
$V_{CES}$	Collector emitter voltage	$V_{GE} = 0 \text{ V}$	$I_C = 1 \text{ mA}$	$T_{VJ} = 25^\circ\text{C}$			650
$V_{GES}$	Maximum DC gate voltage						$\pm 20$
$I_C$	Collector current (depending on thermal properties of assembly)						300
$V_{CE\text{sat}}$	Collector emitter saturation voltage	$V_{GE} = 15 \text{ V}$	$I_C = 290 \text{ A}$	$T_{VJ} = 25^\circ\text{C}$	1.5	1.7	V
				$T_{VJ} = 150^\circ\text{C}$	1.75		V
$V_{TO}$	Threshold voltage	$V_{GE} = 15 \text{ V}$	$T_{VJ} = 175^\circ\text{C}$				0.8
$r_T$	(for power loss calculation)						4.1
$I_{CES}$	Collector emitter leakage current	$V_{CE} = 650 \text{ V}$	$V_{GE} = 0 \text{ V}$	$T_{VJ} = 25^\circ\text{C}$	10	100	$\mu\text{A}$
				$T_{VJ} = 150^\circ\text{C}$	100		$\mu\text{A}$
$I_{GES}$	Gate emitter leakage current	$V_{CE} = 0 \text{ V}$	$V_{GE} = \pm 20 \text{ V}$				500
$V_{GE(\text{th})}$	Gate emitter threshold voltage	$I_C = 4 \text{ mA}$	$V_{CE} = V_{GE}$	$T_{VJ} = 25^\circ\text{C}$	5	5.8	6.5
$Q_{Gon}$	Total gate charge	$I_C = 300 \text{ A}$	$V_{CE} = 300 \text{ V}$	$V_{GE} = 15 \text{ V}$		530	nC
$C_{ies}$	Input capacitance				12.36		nF
$C_{oes}$	Output capacitance	$V_{CE} = 25 \text{ V}$	$V_{GE} = 0 \text{ V}$	$T_{VJ} = 25^\circ\text{C}$	tbd		pF
$C_{res}$	Reverse transfer capacitance	$f = 1 \text{ MHz}$			tbd		pF
$t_{d(on)}$	Turn-on delay time					25	ns
$t_r$	Current rise time					45	ns
$t_{d(off)}$	Turn-off delay time	$V_G = 300 \text{ V}$	$I_C = 300 \text{ A}$			120	ns
$t_f$	Current fall time	$R_G = 3.3 \Omega$	$V_{GE} = \pm 15 \text{ V}$	$T_{VJ} = 150^\circ\text{C}$		40	ns
$E_{on}$	Turn-on energy per pulse			measured with: DMHP 107-067M		7	mJ
$E_{off}$	Turn-off energy per pulse					12	mJ
<b>RBSOA</b>	Reverse bias safe operation area	$V_{GE} = 15 \text{ V}$	$R_G = 3.3 \Omega$	$T_{VJ} = 150^\circ\text{C}$			
				$V_{CE} = 650 \text{ V}$			600
<b>SCSOA</b>	Short circuit safe operation area						
$t_{sc}$	Short circuit duration	$V_{CE} = 360 \text{ V}$	$V_{GE} = \pm 15 \text{ V}$	$T_{VJ} = 150^\circ\text{C}$		10	$\mu\text{s}$
$I_{sc}$	Short circuit current	$R_G = 3.3 \Omega$	non-repetitive			1200	A

Data according to IEC 60747

## Dimensions (1 mm = 0.0394")

